



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 245818US2	SHEET 1 OF 1		SERIAL NO. 10/720,133
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Takashi FUJIWARA					
		FILING DATE November 25, 2003		GROUP 2106-2143			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/A.S.	AA	5,701,413	12/23/1997	Ferruccio ZULIAN, et al. (corresponding to JP 7-311751; previously filed on April 13, 2006)			
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
/A.S./	AO	EP 0 608 663 B1	08/03/1994	Europe (corresponding to JP 7-311751; previously filed on April 13, 2006)			
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner		/Anish Sikri/ (07/28/2007)				Date Considered 07/28/2007	
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							



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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takashi FUJIWARA				
				FILING DATE November 25, 2003	GROUP 2188 2143			
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
/A.S./	AA							
	AB							
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	AN							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION			
	AO	7-311751	11/28/1995	JAPAN (with English Abstract)	YES		X	
	AP	1-154273	06/16/1989	JAPAN (with English Abstract)	YES		X	
↓	AQ	8-263459	10/11/1996	JAPAN (with English Abstract)	YES		X	
	AR	2001-142777	05/25/2001	JAPAN (with English Abstract)	YES		X	
/A.S./	AS	6-4401	01/14/1994	JAPAN (with English Abstract)	YES		X	
	AT				YES			
	AU				YES			
	AV				YES			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AW							
	AX							
	AY							
	AZ					<input type="checkbox"/> Additional References sheet(s) attached		
Examiner /Anish Sikri/ (07/28/2007)					Date Considered 07/28/2007			

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 245818US2		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT					
		Takashi FUJIWARA		FILING DATE HEREWITH 11/25/03		GROUP 2143	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
/A.S./	AA	4,669,056	05/26/87	Donald E. WALDECKER, et al.			
/A.S./	AB	6,026,454	02/15/00	Gary Leon COHEN			
	AC						
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	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
	AO				YES	NO	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner /Anish Sikri/ (07/28/2007)					Date Considered 07/28/2007		
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